

High Speed IGBT

IXSP 20N60B2 IXSP 20N60B2D1

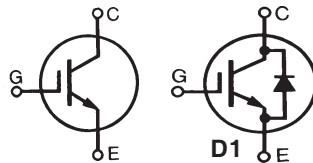
$$V_{CES} = 600 \text{ V}$$

$$I_{C25} = 35 \text{ A}$$

$$V_{CE(sat)} = 2.5 \text{ V}$$

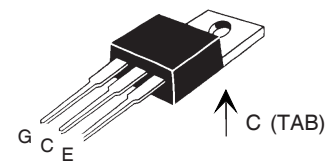
Short Circuit SOA Capability

Preliminary Data Sheet



| Symbol | Test Conditions | Maximum Ratings | |
|---|--|----------------------------------|------------------|
| V_{CES} | $T_J = 25^\circ\text{C to } 150^\circ\text{C}$ | 600 | V |
| V_{CGR} | $T_J = 25^\circ\text{C to } 150^\circ\text{C}; R_{GE} = 1 \text{ M}\Omega$ | 600 | V |
| V_{GES} | Continuous | ± 20 | V |
| V_{GEM} | Transient | ± 30 | V |
| I_{C25} | $T_C = 25^\circ\text{C}$ | 35 | A |
| I_{C110} | $T_C = 110^\circ\text{C}$ | 20 | A |
| $I_{F(110)}$ | | 11 | A |
| I_{CM} | $T_C = 25^\circ\text{C}, 1 \text{ ms}$ | 60 | A |
| SSOA (RBSOA) | $V_{GE} = 15 \text{ V}, T_J = 125^\circ\text{C}, R_G = 82 \Omega$ Clamped inductive load | $I_{CM} = 32$ @ $0.8 V_{CES}$ | A |
| t_{SC} (SCSOA) | $V_{GE} = 15 \text{ V}, V_{CE} = 360 \text{ V}, T_J = 125^\circ\text{C}$ $R_G = 82 \Omega$, non repetitive | 10 | μs |
| P_C | $T_C = 25^\circ\text{C}$ | 190 | W |
| T_J | | -55 ... +150 | $^\circ\text{C}$ |
| T_{JM} | | 150 | $^\circ\text{C}$ |
| T_{stg} | | -55 ... +150 | $^\circ\text{C}$ |
| Weight | | 2 | g |
| Maximum lead temperature for soldering 1.6 mm (0.062 in.) from case for 10 s | | 300 | $^\circ\text{C}$ |
| Maximum tab temperature for soldering for 10s | | 260 | $^\circ\text{C}$ |

TO-220AB (IXSP)



G = Gate C = Collector
E = Emitter TAB = Collector

Features

- International standard package
- Guaranteed Short Circuit SOA capability
- Low $V_{CE(sat)}$
 - for low on-state conduction losses
- High current handling capability
- MOS Gate turn-on
 - drive simplicity
- Fast fall time for switching speeds up to 20 kHz

Applications

- AC motor speed control
- Uninterruptible power supplies (UPS)
- Welding

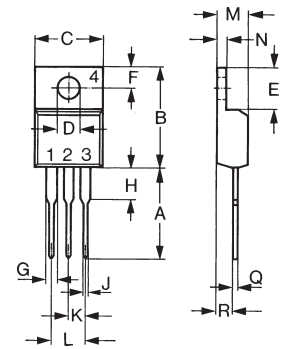
Advantages

- High power density

| Symbol | Test Conditions | Characteristic Values ($T_J = 25^\circ\text{C}$, unless otherwise specified) | | |
|---------------|---|---|------|--------------------------------------|
| | | min. | typ. | max. |
| BV_{CES} | $I_C = 250 \mu\text{A}, V_{GE} = 0 \text{ V}$ | 600 | | V |
| $V_{GE(th)}$ | $I_C = 750 \mu\text{A}, V_{CE} = V_{GE}$ | 3.5 | | V |
| I_{CES} | $V_{CE} = V_{CES}$ $V_{GE} = 0 \text{ V}$ | SP20N60B2 SP20N60B2D1 | | 25 μA 85 μA |
| I_{GES} | $V_{CE} = 0 \text{ V}, V_{GE} = \pm 20 \text{ V}$ | | | $\pm 100 \text{ nA}$ |
| $V_{CE(sat)}$ | $I_C = 16 \text{ A}, V_{GE} = 15 \text{ V}$ | | | 2.5 V |

DS99181A(07/04)

| Symbol | Test Conditions | Characteristic Values ($T_J = 25^\circ\text{C}$, unless otherwise specified) | | |
|--------------|---|---|------|-------------------|
| | | min. | typ. | max. |
| g_{fs} | $I_C = 16\text{A}; V_{CE} = 10\text{V}$, Note 1 | 3.5 | 7.0 | S |
| C_{ies} | | | 800 | pF |
| C_{oes} | $V_{CE} = 25\text{V}, V_{GE} = 0\text{V}$ $f = 1\text{MHz}$ | | 76 | pF |
| | 20N60B2D1 | | 90 | pF |
| C_{res} | | | 28 | pF |
| Q_g | | | 33 | nC |
| Q_{ge} | $I_C = 16\text{A}, V_{GE} = 15\text{V}, V_{CE} = 0.5 V_{CES}$ | | 12 | nC |
| Q_{gc} | | | 12 | nC |
| $t_{d(on)}$ | Inductive load, $T_J = 25^\circ\text{C}$ | | 30 | ns |
| t_{ri} | $I_C = 16\text{A}, V_{GE} = 15\text{V}$ $V_{CE} = 0.8 V_{CES}, R_G = 10\ \Omega$ | | 30 | ns |
| $t_{d(off)}$ | Switching times may increase for V_{CE} (Clamp) $> 0.8 \cdot V_{CES}$, higher T_J or increased R_G | | 116 | ns |
| t_{fi} | | | 126 | ns |
| E_{off} | | | 380 | 600 μJ |
| $t_{d(on)}$ | Inductive load, $T_J = 125^\circ\text{C}$ | | 30 | ns |
| t_{ri} | | | 30 | ns |
| E_{on} | $I_C = 16\text{A}, V_{GE} = 15\text{V}$ $V_{CE} = 0.8 V_{CES}, R_G = 10\ \Omega$ | 20N60B2 | 0.12 | mJ |
| | | 20N60B2D1 | 0.42 | mJ |
| $t_{d(off)}$ | Switching times may increase for V_{CE} (Clamp) $> 0.8 \cdot V_{CES}$, higher T_J or increased R_G | | 180 | ns |
| t_{fi} | | | 210 | ns |
| E_{off} | | | 970 | μJ |
| R_{thJC} | | | | 0.66 K/W |
| R_{thCS} | | | 0.3 | K/W |

TO-220 AB (IXSP) Outline


| Dim. | Millimeter | | Inches | |
|------|------------|-------|--------|-------|
| | Min. | Max. | Min. | Max. |
| A | 12.70 | 13.97 | 0.500 | 0.550 |
| B | 14.73 | 16.00 | 0.580 | 0.630 |
| C | 9.91 | 10.66 | 0.390 | 0.420 |
| D | 3.54 | 4.08 | 0.139 | 0.161 |
| E | 5.85 | 6.85 | 0.230 | 0.270 |
| F | 2.54 | 3.18 | 0.100 | 0.125 |
| G | 1.15 | 1.65 | 0.045 | 0.065 |
| H | 2.79 | 5.84 | 0.110 | 0.230 |
| J | 0.64 | 1.01 | 0.025 | 0.040 |
| K | 2.54 | BSC | 0.100 | BSC |
| M | 4.32 | 4.82 | 0.170 | 0.190 |
| N | 1.14 | 1.39 | 0.045 | 0.055 |
| Q | 0.35 | 0.56 | 0.014 | 0.022 |
| R | 2.29 | 2.79 | 0.090 | 0.110 |

| Symbol | Test Conditions | Characteristic Values ($T_J = 25^\circ\text{C}$, unless otherwise specified) | | |
|------------|--|---|------|------------------|
| | | min. | typ. | max. |
| V_F | $I_F = 10\text{A}, V_{GE} = 0\text{V}$ | $T_J = 150^\circ\text{C}$ | | 1.66 V 2.66 V |
| I_{RM} | $I_F = 12\text{A}, V_{GE} = 0\text{V}, -di_F/dt = 100\text{A}/\mu\text{s}$ | $T_J = 100^\circ\text{C}$ | 1.5 | A |
| t_{rr} | $V_R = 100\text{V}$ | $T_J = 100^\circ\text{C}$ | 90 | ns |
| t_{rr} | $I_F = 1\text{A}; -di/dt = 100\text{A}/\mu\text{s}; V_R = 30\text{V}$ | | 30 | ns |
| R_{thJC} | | | | 2.5 K/W |

Note 1: Pulse test, $t \leq 300\ \mu\text{s}$, duty cycle $d \leq 2\%$

IXYS reserves the right to change limits, test conditions, and dimensions.

IXYS MOSFETs and IGBTs are covered by one or more of the following U.S. patents: 4,835,592 4,881,106 5,017,508 5,049,961 5,187,117 5,381,025 6,162,665 6,306,728 B1 6,534,343 6,683,344 4,850,072 4,931,844 5,034,796 5,063,307 5,237,481 5,486,715 6,259,123 B1 6,404,065 B1 6,583,505 6,710,405 B2

Fig. 1. Output Characteristics @ 25 °C

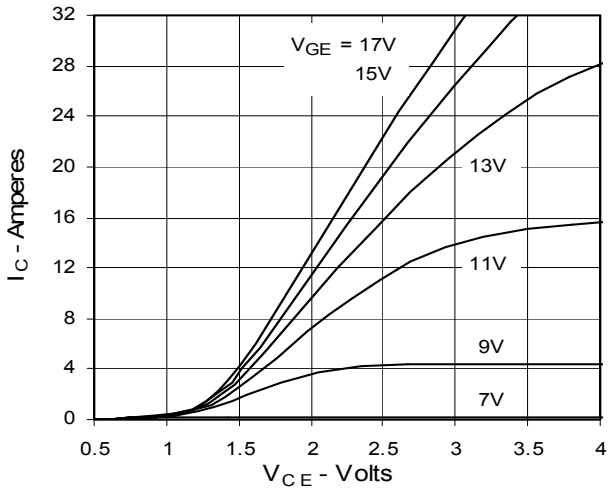


Fig. 2. Extended Output Characteristics @ 25 °C

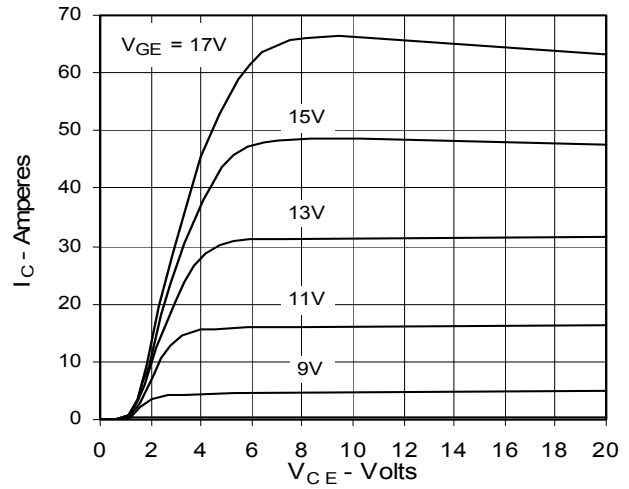


Fig. 3. Output Characteristics @ 125 °C

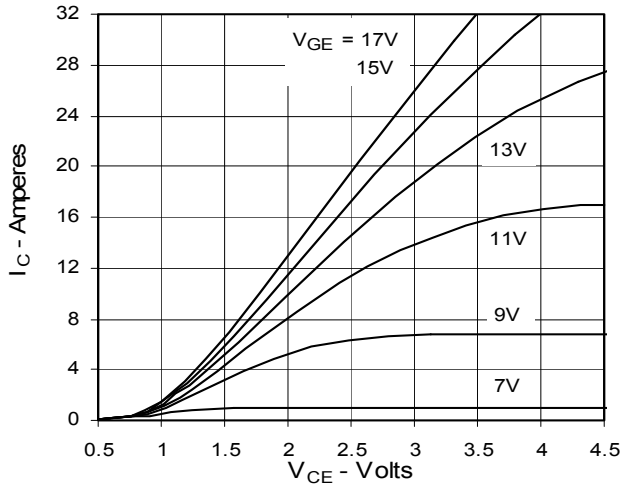


Fig. 4. Dependence of $V_{CE(sat)}$ on Temperature

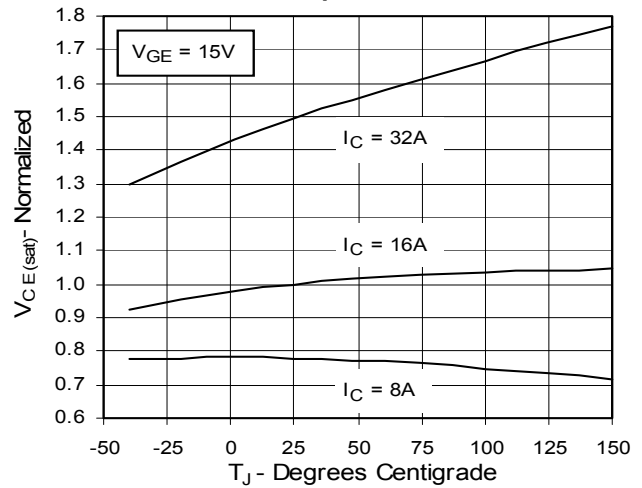


Fig. 5. Collector-to-Emitter Voltage vs. Gate-to-Emitter voltage

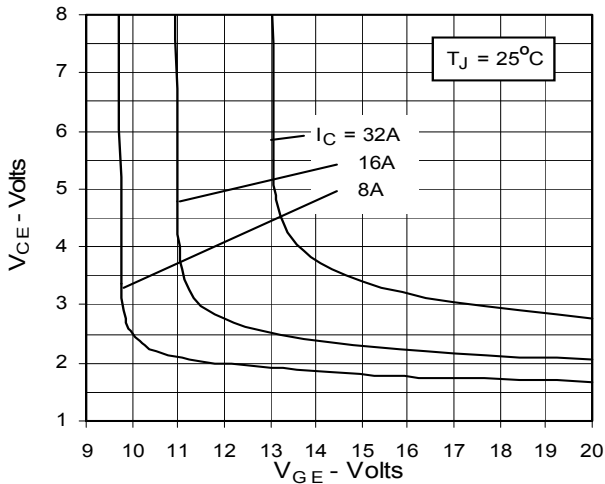


Fig. 6. Input Admittance

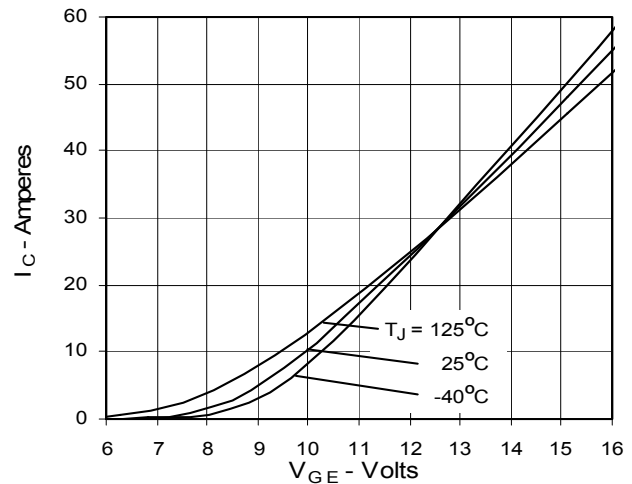


Fig. 7. Transconductance

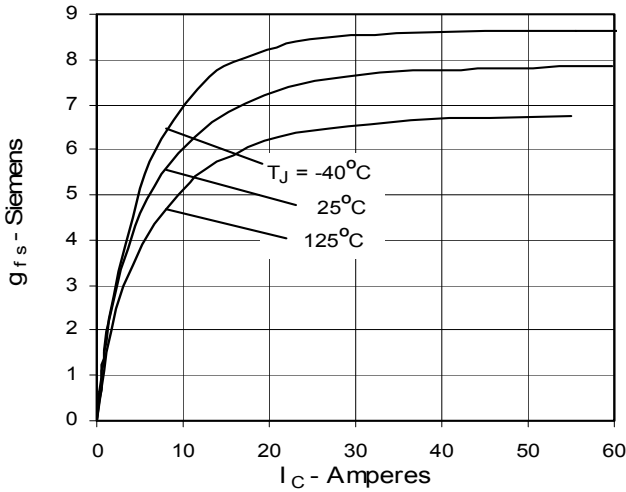


Fig. 8. Dependence of Turn-off Energy Loss on R_G

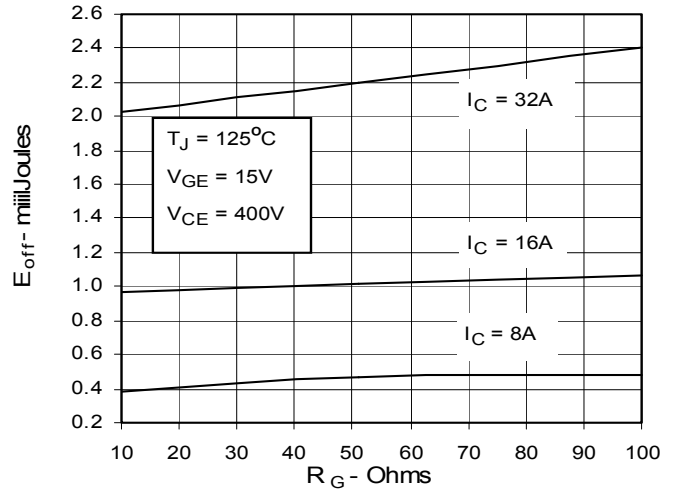


Fig. 9. Dependence of Turn-Off Energy Loss on I_C

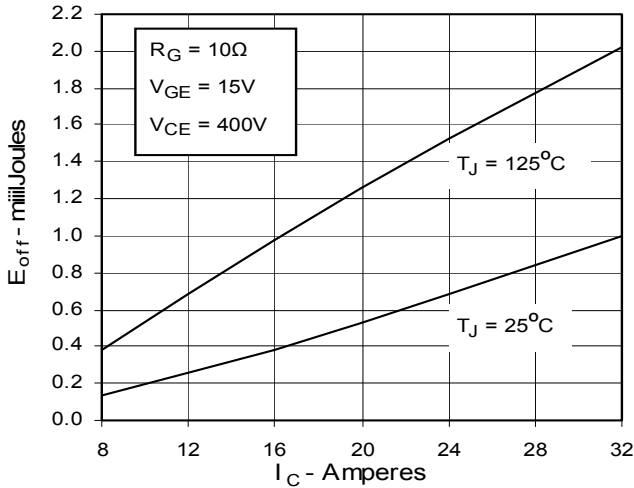


Fig. 10. Dependence of Turn-off Energy Loss on Temperature

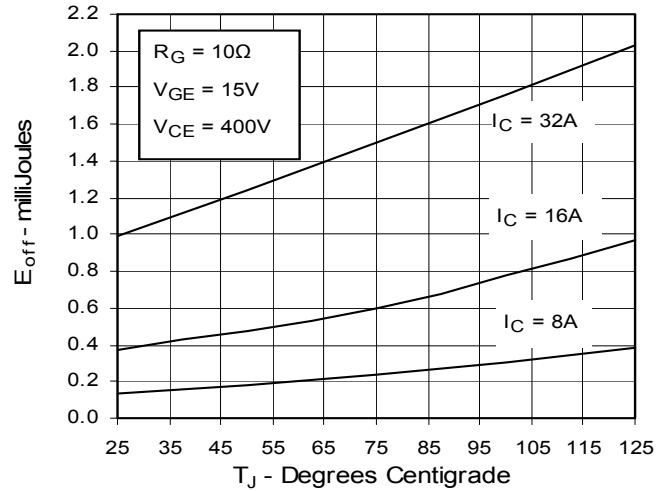


Fig. 11. Dependence of Turn-off Switching Time on R_G

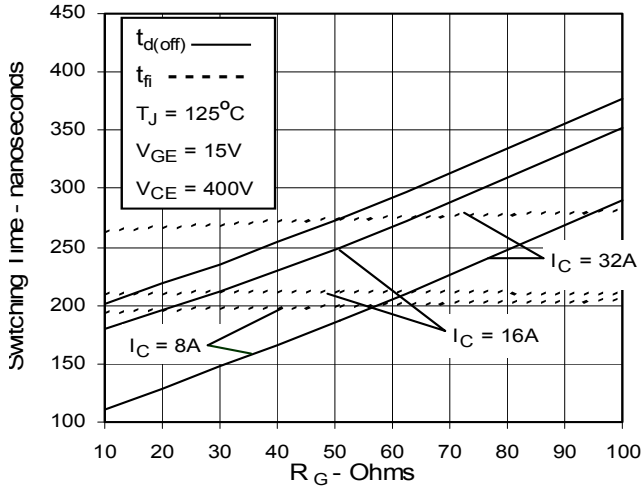


Fig. 12. Dependence of Turn-off Switching Time on I_C

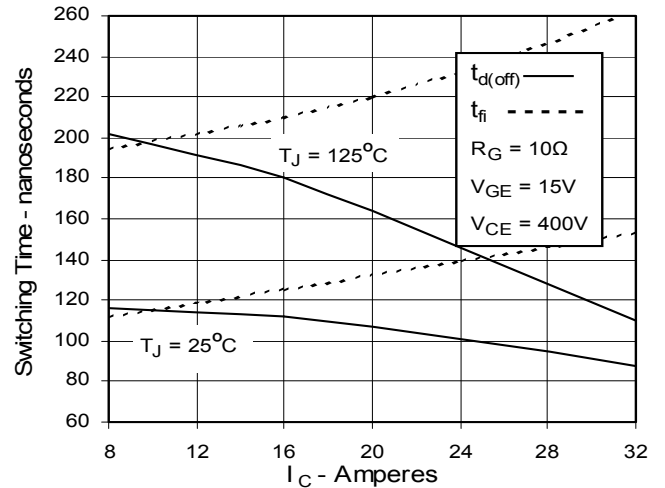


Fig. 13. Dependence of Turn-off Switching Time on Temperature

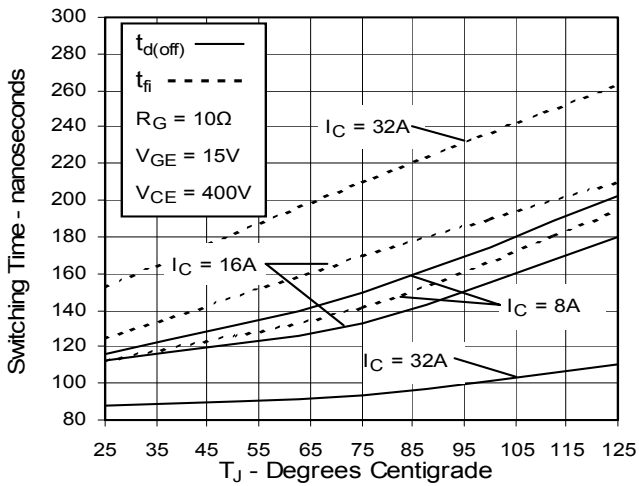


Fig. 14. Gate Charge

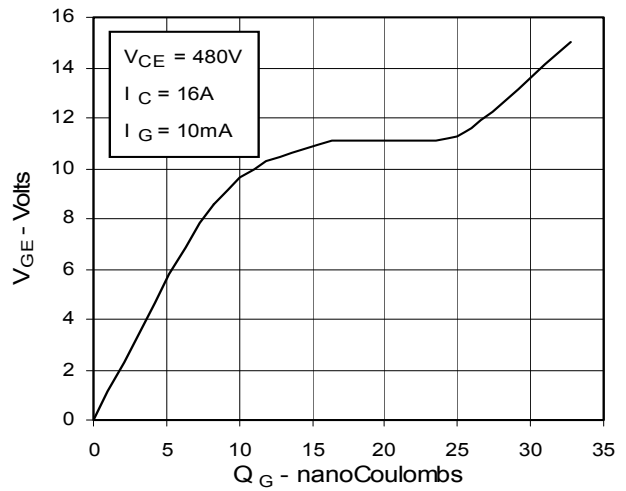


Fig. 15. Capacitance

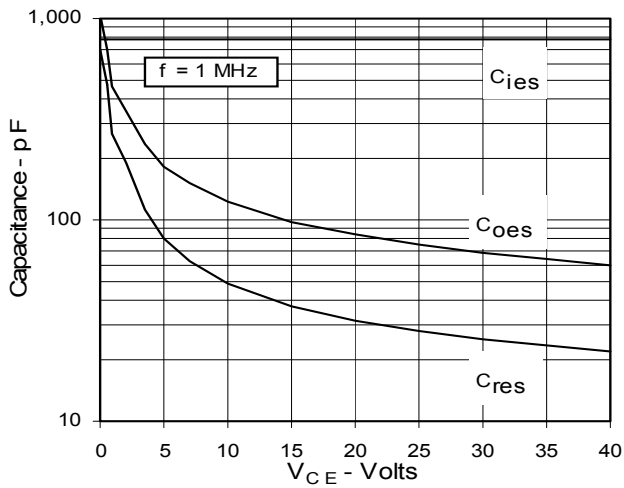


Fig. 16. Reverse-Bias Safe Operating Area

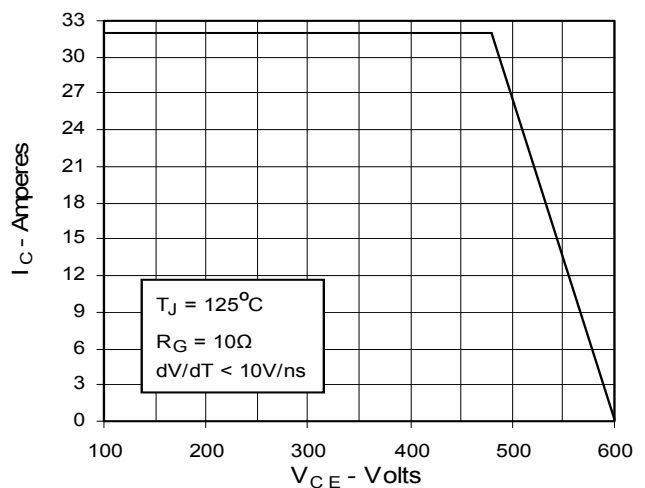
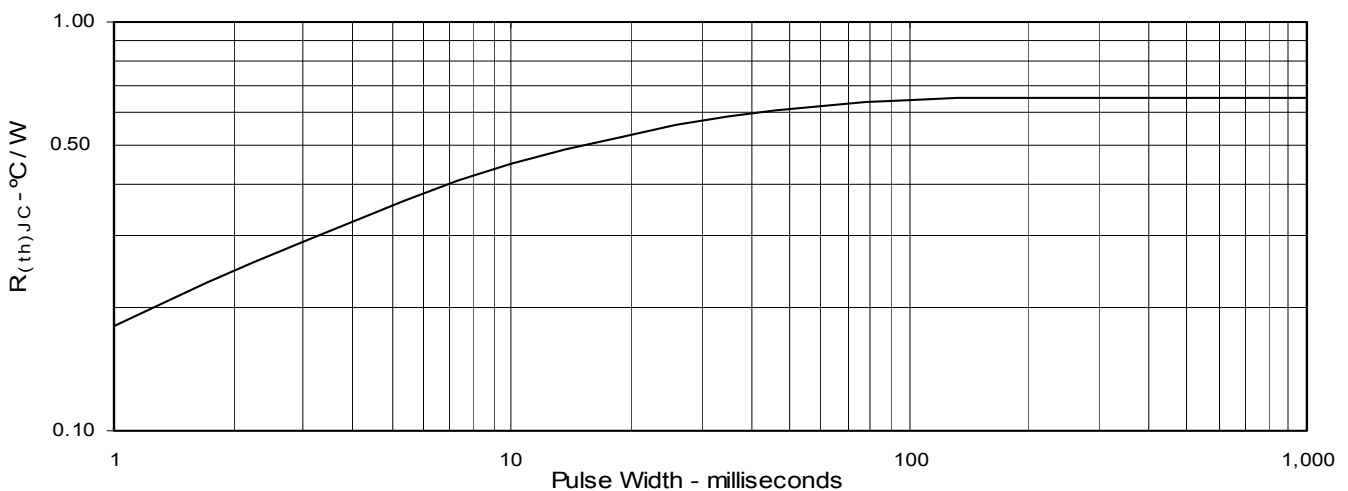


Fig. 17. Maximum Transient Thermal Resistance



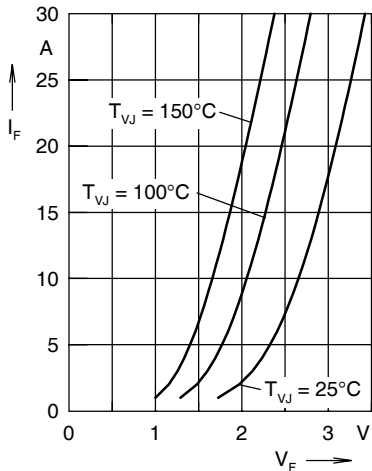


Fig. 18. Forward current I_F versus V_F

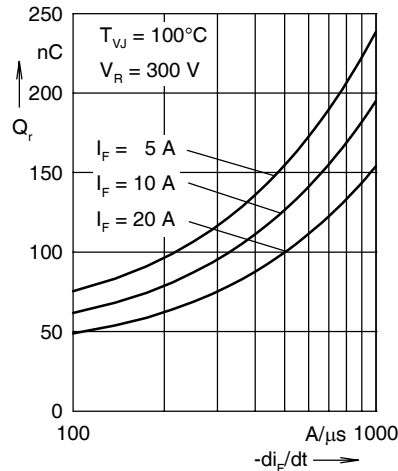


Fig. 19. Reverse recovery charge Q_r

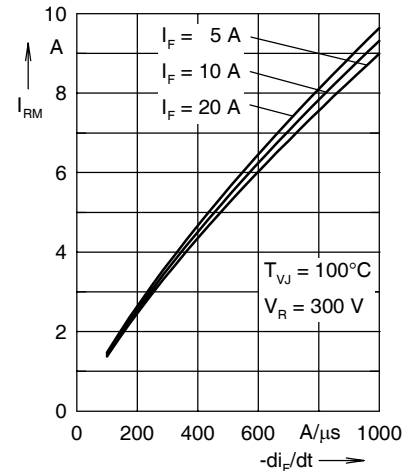


Fig. 20. Peak reverse current I_{RM}

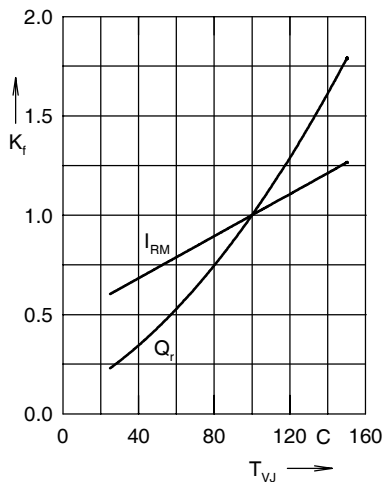


Fig. 21. Dynamic parameters Q_r , I_{RM}

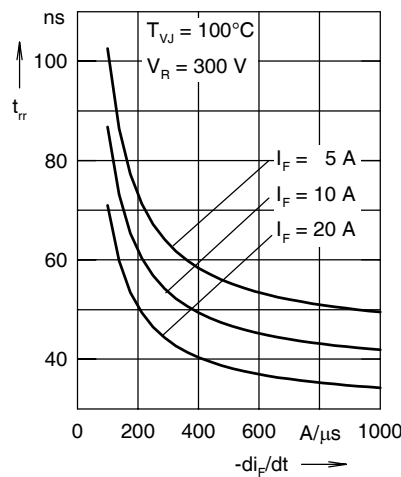


Fig. 22. Recovery time t_{rr} versus $-di_F/dt$

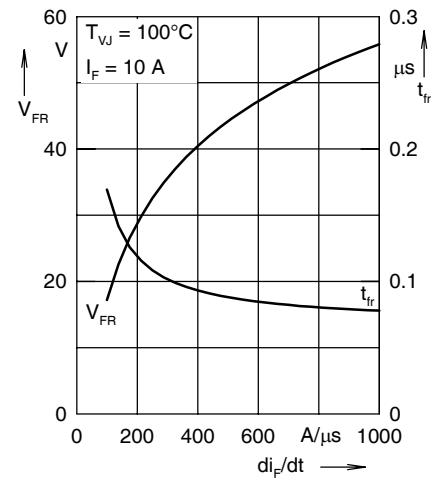


Fig. 23. Peak forward voltage V_{FR} and t_{fr}

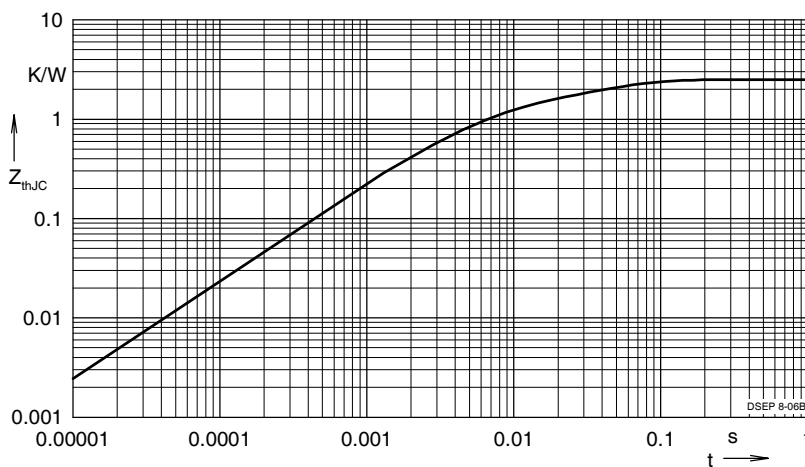


Fig. 24. Transient thermal resistance junction-to-case

Constants for Z_{thJC} calculation:

| i | R_{thi} (K/W) | t_i (s) |
|---|-----------------|-----------|
| 1 | 1.449 | 0.0052 |
| 2 | 0.5578 | 0.0003 |

NOTE: Fig. 18 to Fig. 23 shows typical values

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| | | | | | | | | | |
|-----------|-----------|-----------|-----------|-----------|-----------|--------------|--------------|-----------|--------------|
| 4,835,592 | 4,881,106 | 5,017,508 | 5,049,961 | 5,187,117 | 5,381,025 | 6,162,665 | 6,306,728 B1 | 6,534,343 | 6,683,344 |
| 4,850,072 | 4,931,844 | 5,034,796 | 5,063,307 | 5,237,481 | 5,486,715 | 6,259,123 B1 | 6,404,065 B1 | 6,583,505 | 6,710,405 B2 |